

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10608685	BURRELL, BRANDON	
Examiner	Art Unit		
LE NGUYEN	2174		

SEARCHED

Class	Subclass	Date	Examiner
715	760	1/3/08	lvn

SEARCH NOTES

Search Notes	Date	Examiner
EPO, JPO, ACM library, IEEE Xplore; US-PGPub, USPAT: 713/1,2,100, 700/17, 715/513,529,760	1/3/08	lvn

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
715	760	1/3/08	lvn